

PRODUCT / PROCESS CHANGE NOTIFICATION

AS39xx NFC / RFID Reader IC Products purchased from ams AG

What is the change?

In a first phase (Phase 1):

- The **ordering part numbers** of the **AS39xx NFC / RFID readers** will change from **AS39**xx-yyyy to **ST25R39**xx-yyyy for the HF readers and **ST25RU39**xx-yyyy for the UHF readers.
- The labelling will change as well, following the new ST ordering part numbers.
- Reel size will be standardized to 13 inches diameter with one single minimum bulk order quantity.
- For wafer deliveries, the wafer maps file name will change.

In a second phase (Phase 2):

- The final test & finishing location will move from ams (Philippines) to KYEC (Taiwan).
- The marking will change from AS39xx to 25R39xx.
- The labelling will change to standard ST label.

The die of the IC's remains the same and wafers are still produced in the same factories as before. No functionality or parameter changes will be applied. The package remain unchanged and is still done by the same sub-contractors as before.

New orders for deliveries that shall occur after January 1st 2017 must be placed to STMicroelectronics based on the new ordering part number.

Whv?

Because of the recent purchase of the NFC/RFID readers business acquired from ams AG, STMicroelectronics requires to migrate the purchase orders from ams to STMicroelectronics.

When?

- Orders to ST of the new part numbers are possible upon receiving this document
- The delivery with the new ordering part numbers will start from January 1st 2017.
- The **shipment** of parts with the **new marking** will start **from May 2017** on.

How will the change be qualified?

The new KYEC test location will be qualified using the standard ST Microelectronics Corporate Procedures for Quality & Reliability.

What is the impact of the change?

- Form: Marking change (phase 2 only)

- Fit: No change

- Function: No change

How can the change be seen?

- CURRENT ams INNER BOX LABEL

19	MPN 2310012	@ C	ımı
(P)	Ord. Code AS391	11B-AQFT	LS ASP85
(9D) Date Code1 1626XBG	(9D) Date Code2	AT COO	(S) Serial No
(1T) Supplier Lot No 116594	(2T) Supp	oller Lot No	2324
(1T) Supplier Lot No 116594 (V) Supplier Info: 19			(C) Cry 2324

- PHASE 1 INNER BOX LABEL: Modified ams label with ST logo, new ST ordering part numbers and bulk ID.



- PHASE 2 INNER BOX LABEL (ST standard label)

→ Example for ST25R3911B-AQFT



- DEVICE MARKING:

- Example for QFN: AS3911B

Current ams marking



Legend:

AS3911B = Product name YY = Assembly year

WW = Assembly week

X = Subcon. assembly code

ZZ = Sequence

@ = Sublot id

New ST marking



Legend:

25R3911B = Product name

PP = Assembly plant

LLL = Sequence

WX = Wafer plant

HHH = Country of origin

Y = Assembly year

WW = Assembly week

- INKLESS WAFER MAP FILE NAME CHANGE:

The new file name of the wafer maps will be **Lot ID_ZIP.ZIP** (ZIP file will contain same ANAM file format as before).

Appendix A- Product Change Information

Product family / Commercial products:	NFC/RFID readers
Customer(s):	All
Type of change:	 Ordering/labelling part number change Final test & finishing location/marking change
Reason for the change:	ams AG NFC/RFID readers business was acquired by STMicroelectronics
Description of the change:	 Phase 1: New ST ordering part numbers Phase 2: Final Test & finishing location change from ams (Philippines) to KYEC (Taiwan)
Forecast date of the change: (Notification to customer)	 Phase 1: January 1st 2017 Phase 2: Starting May 2017
Forecast date of Qualification samples availability for customer(s):	See details in APPENDIX B
Forecast date for the internal STMicroelectronics change, Qualification Report availability:	See Qualification Plan inside this document
Marking to identify the changed product:	HF readers: 25R39xx UHF readers 25RU39xx
Description of the qualification program:	Standard ST Microelectronics Corporate Procedures for Quality and Reliability See details in APPENDIX D
Product Line(s) and/or Part Number(s):	See APPENDIX B
Estimated date of first shipment:	See details in APPENDIX C

Appendix B: Concerned Commercial Part Numbers:

Reader	ams part number	ST part number	Package	Qualification samples (Phase 2)
HF	AS3909-BQTT	CT3FD3000 DOTT	OENSS	Not applicable (*)
HF	AS3909-BQTM	ST25R3909-BQTT	QFN32	Not applicable (*)
HF	AS3910-BQFT	ST25R3910-BQFT	QFN32	June 2017
HF	AS3911-BQFT	ST25R3911-BQFT	QFN32	May 2017
HF	AS3911B-AQFT	ST25R3911B-AQFT	QFN32	May 2017
HF	AS3911B-AQFM	3123K3311B-AQF1	QFN32	May 2017
HF	AS3911B-ASWB	ST25R3911B-ASWB	Wafer	September 2017
HF	AS3912-BQFM	ST25R3912-BQFT	QFN32	May 2017
HF	AS3913-BQFM	ST25R3913-BQFT	QFN32	May 2017
HF	AS3914-AQFT	ST25R3914-AQFT	QFN32	4Q 2017
HF	AS3914-AQFM	3123K3314-AQF1	QFN32	4Q 2017
HF	AS3915-AQFT	ST25R3915-AQFT	QFN32	4Q 2017
HF	AS3915-AQFM	3123N3313-AQF1	QI N32	4Q 2017
UHF	AS3980-BQFT	ST25RU3980-BQFT	QFN48	May 2017
UHF	AS3980-BQFM	3123N03380-DQF1	Q1 N40	Iviay 2017
UHF	AS3991-BQFT	ST25RU3991-BQFT	QFN64	Not applicable (**)
UHF	AS3991-BQFM	3123N03331-BQF1	QFIN04	Not applicable (**)
UHF	AS3992-BQFT	ST25RU3992-BQFT	QFN64	May 2017
UHF	AS3992-BQFM	3123N03332-DQF1	QI NO4	IVIAY ZO17
UHF	AS3993-BQFT	ST25RU3993-BQFT	QFN48	May 2017
UHF	AS3993-BQFM	3123NU3333-BQF1	QFIN40	May 2017

^(*) Customers using the AS3909 product are required to place further orders on the ST25R3910 product, which is equivalent in features.

^(**) Customers using the AS3991 product are required to place further orders on the ST25R3992 product, which is equivalent in features.

Appendix C: Timeline for each product:

ams part number	ST part number	from Jan 1 st 2017	
AS3909-BQTT	ST25R3909-BQTT	Ordering/Labelling: Phase 1 label Wafer fab: ams, no change	
AS3909-BQTM		Assembly location: ASE, no change	
AS3991-BQFT	CT2FDU2004 BOFT	T&F location: ams, no change	
AS3991-BQFM	ST25RU3991-BQFT	Marking: ams, no change	

ams	ST	Phase 1	Phase 2	
part number	part number	from Jan 1 st 2017	from May 2017	
AS3910-BQFT	ST25R3910-BQFT	Ordering/Labelling: Phase 1 label Wafer fab: ams, no change Assembly location: ASE, no change	Ordering/Labelling: Phase 2 label ams, no change ASE, no change	
AS3911-BQFT	ST25R3911-BQFT	T&F location: ams, no change Marking: ams, no change	New KYEC test location New ST marking	
AS3911B-AQFT		Ordering/Labelling: Phase 1 label	Ordering/Labelling: Phase 2 label	
AS3911B-AQFM	ST25R3911B-AQFT	Wafer fab: TSMC, no change	TSMC, no change	
AS3912-BQFM	ST25R3912-BQFT	Assembly location: ASE, no change T&F location: ams, no change	ASE, no change New KYEC test location	
AS3913-BQFM	ST25R3913-BQFT	Marking: ams, no change	New ST marking	
AS3914-AQFT		Ordering/Labelling: Phase 1 label	Ordering/Labelling: Phase 2 label	
AS3914-AQFM	ST25R3914-AQFT	Wafer fab: ams, no change	ams, no change	
AS3915-AQFT		Assembly location: ASE, no change	ASE, no change	
	ST25R3915-AQFT	T&F location: ams, no change	New KYEC test location	
AS3915-AQFM	·	Marking: ams, no change	New ST marking	
AS3911B-ASWB	ST25R3911B-ASWB	Ordering/Labelling: Phase 1 label Wafer fab: TSMC, no change T&F location: ams, no change New ST inkless file name	Ordering/Labelling: Phase 2 label TSMC, no change New KYEC test location New ST inkless file name	
AS3980-BQFT	CTAFRUADOS BOFT			
AS3980-BQFM	ST25RU3980-BQFT	Ordering/ Labelling: Phase 1 label	Phase 1 label, no change	
AS3992-BQFT	CT250112002 D 2 = -	Wafer fab: ams, no change	ams, no change	
AS3992-BQFM	ST25RU3992-BQFT	Assembly location: ASE, no change T&F location: ams, no change	ASE, no change ams, no change	
AS3993-BQFT	CT250112002 D 2 = -	Marking: ams, no change	New ST marking	
AS3993-BQFM	ST25RU3993-BQFT			

T&F = Test & Finishing

Appendix D: Qualification Plan:

Test	Method	Conditions	Duration	Sample size	Lots	Acceptance Criteria
Automation / program loading	-	-	-		1 lot	No major concern
Electrical test	Correlation exercise	-	-	30 000	1 lot	No major concern No yield degradation 100% bin to bin
Line stressing	Yield follow	Production	3 months	30 000	all lots	No major concern No yield degradation No quality degradation

KYEC test transfer qualification plan

Document Revision History				
Date	Rev.	Description of the Revision		
October 28, 2016	V01	First revision		

Source Documents & Reference Documents			
Source document Title	Rev.:	Date:	



PRODUCT / PROCESS CHANGE NOTIFICATION

AS39xx NFC/RFID Reader IC Products purchased from ams AG

APPROVAL TABLE					
Signed by	Name	Approval signature.	Approval date		
NFC reader competence	Mark DICKSON				
center manager					
NFC reader marketing	Rene WUTTE				
Operation Manuf. Mgr	Nicolas TOURNEUR				
RF Memory Technical	Sylvain FIDELIS				
Marketing Mgr					
Planning Mgr	Sophie NADEAU				
New Product Planning	Pierre-François OGIER				
Qualification Mgr	Jean-Philippe CANDELA				
Doc Control Mgr	Laurence CAZES				
Quality Mgr	Rita PAVANO				
(Last before Div. GM)					
Division Product Mgr:	Benoit RODRIGUES				
Originator	Christian POLI	ı	1		